Applicant(s)/Patent Under Application/Control No. Reexamination 09/910,510 **OBRADOVICH ET AL.** Notice of References Cited Examiner Art Unit Page 1 of 1 2141 Djenane M. Bayard **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 08-2003 Vuoristo et al. 455/433 US-6,603,969 Α US-В US-С US-D US-E US-F US-G US-Н US-US-J USĸ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х